

Notice of References Cited

Application/Control No.

10/580,856

Applicant(s)/Patent Under
Reexamination
DEFAYE ET AL.

Examiner

Jonathan S. Lau

Art Unit

1623

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Benito et al. Journal of the American Chemical Society, 2004, 126, p10355-10363.
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